

# SPECIFICATION

DEVICE NAME : Power MOSFET

TYPE NAME : 2SK2523-01

SPEC. No. : -----

Fuji Electric Co.,Ltd.

This Specification is subject to change without notice.

	DATE	NAME	APPROVED	Fuji Electric Co.,Ltd.		
DRAWN				DWG.NO.	1/11	
CHECKED						

1. Scope  
This specifies Fuji power MOSFET 2SK2523-01
2. Construction N-channel enhancement mode power MOSFET
3. Application for switching
4. Outview TO-220 Outviwe See to 5/11 page
5. Absolute maximum ratings at  $T_c=25^\circ\text{C}$  (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain-source voltage	$V_{DS}$	450	V	
Drain-gate voltage	$V_{DGR}$	450	V	$R_{GS}=20\text{K}\Omega$
Continuous Drain current	$I_D$	$\pm 9$	A	
Pulsed drain current	$I_{Dpulss}$	$\pm 36$	A	
Gate-source voltage	$V_{GS}$	$\pm 30$	V	
Maximum power dissipation	$P_D$	60	W	
Operating and storage temperature range	$T_{ch}$	150	$^\circ\text{C}$	
	$T_{sto}$	-55 ~ +150	$^\circ\text{C}$	

6. Electrical characteristics at  $T_c=25^\circ\text{C}$  (unless otherwise specified)
- Static ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Drain-source breakdown voltage	$BV_{DSS}$	$I_D=1\text{mA}$ $V_{GS}=0\text{V}$	450			V
Gate threshold voltage	$V_{GS(th)}$	$I_D=1\text{mA}$ $V_{DS}=V_{GS}$	2.5	3.0	3.5	V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=450\text{V}$ $V_{GS}=0\text{V}$	$T_{ch}=25^\circ\text{C}$		500	$\mu\text{A}$
	$I_{DSS}$		$T_{ch}=125^\circ\text{C}$		1.0	mA
Gate-source leakage current	$I_{GSS}$	$V_{GS}=\pm 30\text{V}$ $V_{DS}=0\text{V}$		10	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$I_D=4.5\text{A}$ $V_{GS}=10\text{V}$		0.87	1.0	$\Omega$

Dynamic ratings.

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Forward transconductance	$g_{fs}$	$I_D = 4.5A$ $V_{DS} = 25V$	3.0	6.6		S
Input capacitance	$C_{iss}$	$V_{DS} = 25V$ $V_{GS} = 0V$ $f = 1MHz$		1150	1700	pF
Output capacitance	$C_{oss}$			130	200	pF
Reverse transfer capacitance	$C_{rss}$			50	75	pF
Turn-on time	$t_{d(on)}$	$V_{CC} = 300V$ $V_{GS} = 10V$ $I_D = 9A$ $R_{GS} = 10\Omega$		20	30	ns
	$t_r$			50	75	ns
Turn-off time	$t_{d(off)}$			60	90	ns
	$t_f$			35	55	ns

Reverse diode

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Avalanche capability	$I_{AV}$	$L = 100\mu H$ , $T_{ch} = 25^\circ C$ ‡ see Fig1 and Fig2	9.0			A
Diode forward on-voltage	$V_{SD}$	$I_F = 2 \times I_{DR}$ $V_{GS} = 0V$ , $T_{ch} = 25^\circ C$		1.1	1.65	V
Reverse recovery time	$t_{rr}$	$I_F = I_{DR}$ $V_{GS} = 0V$ $-di_F/dt = 100A/\mu s$ $T_{ch} = 25^\circ C$		550		ns
Reverse recovery charge	$Q_{rr}$				3.9	

7. Thermal resistance

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Thermal resistance	$R_{th_{ch-c}}$				2.08	$^\circ C/W$
	$R_{th_{ch-a}}$				75	$^\circ C/W$

Fig.1 Test circuit

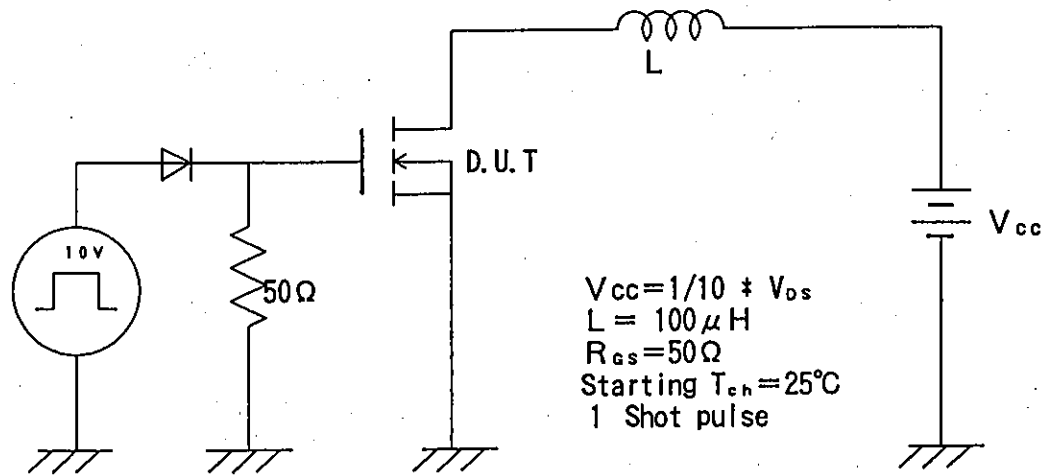
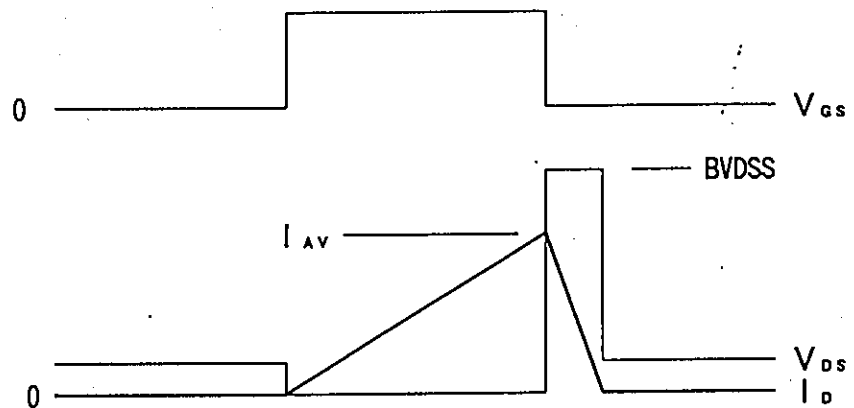
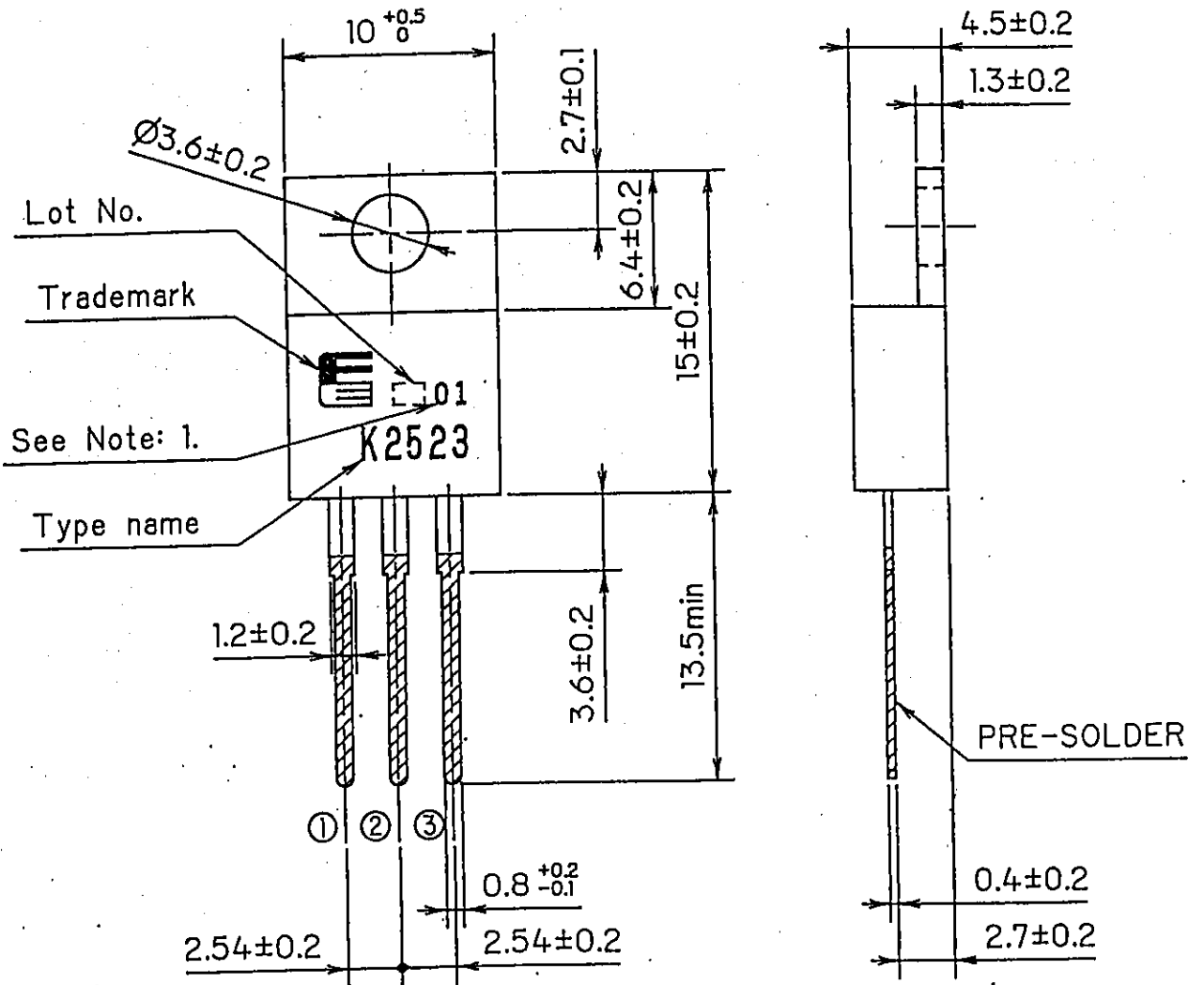


Fig.2 Operating waveforms

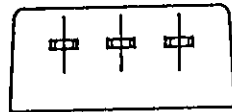


# FUJI POWER MOS FET

TYPE : 2SK2523-01



## CONNECTION



① ② ③

- ① GATE
- ② DRAIN
- ③ SOURCE

JEDEC : TO-220AB

Note: 1. Guaranteed mark of avalanche ruggedness.

DIMENSIONS ARE IN MILLIMETERS.

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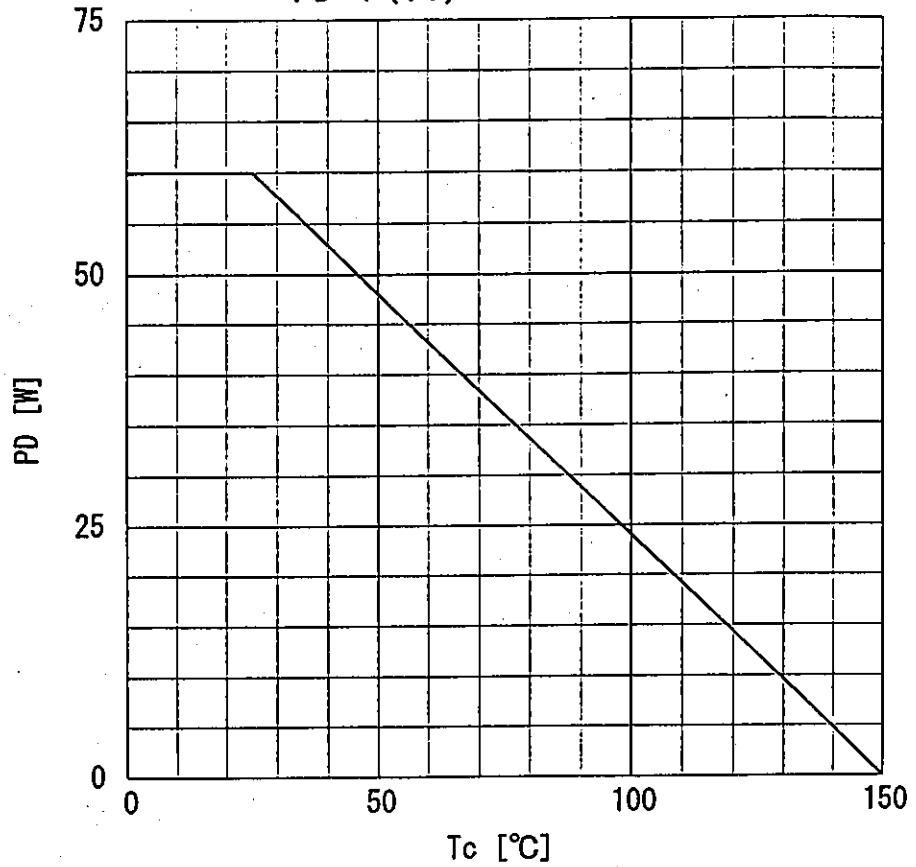
DWG. NO.

5/11

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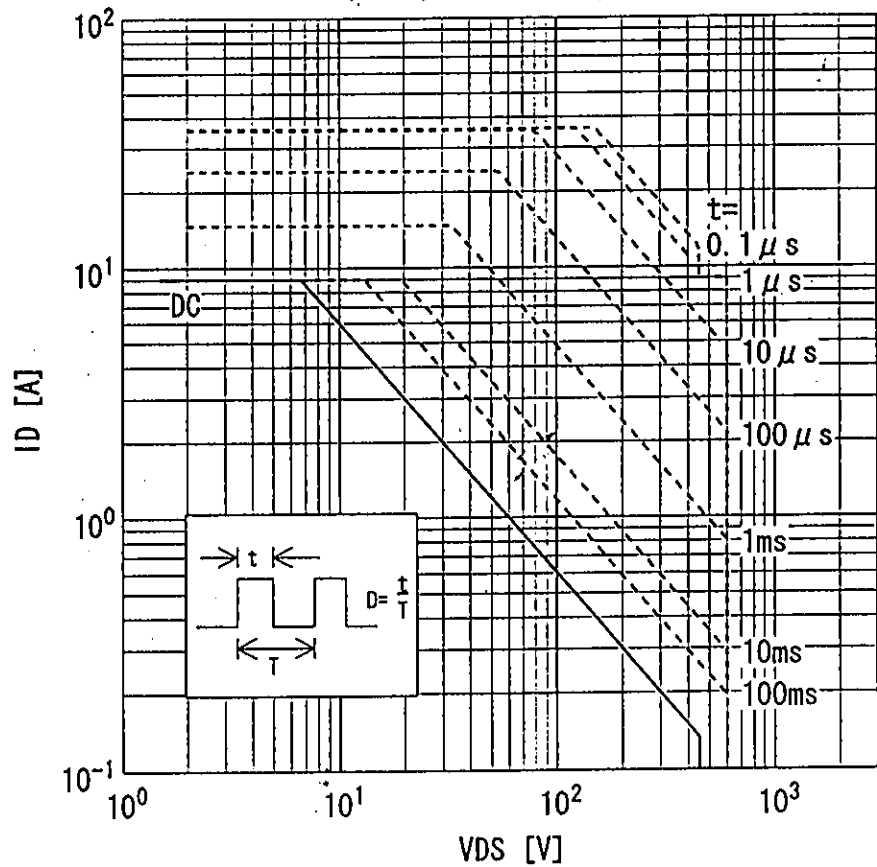
### Power Dissipation

$$PD = f(T_c)$$

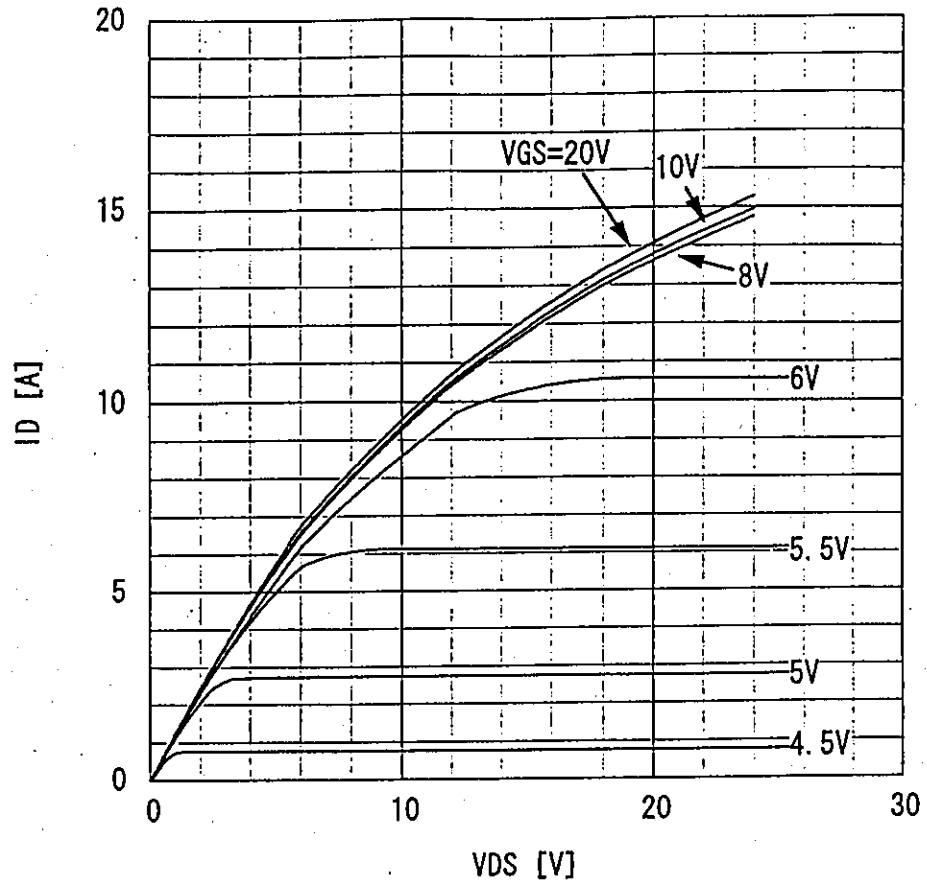


### Safe operating area

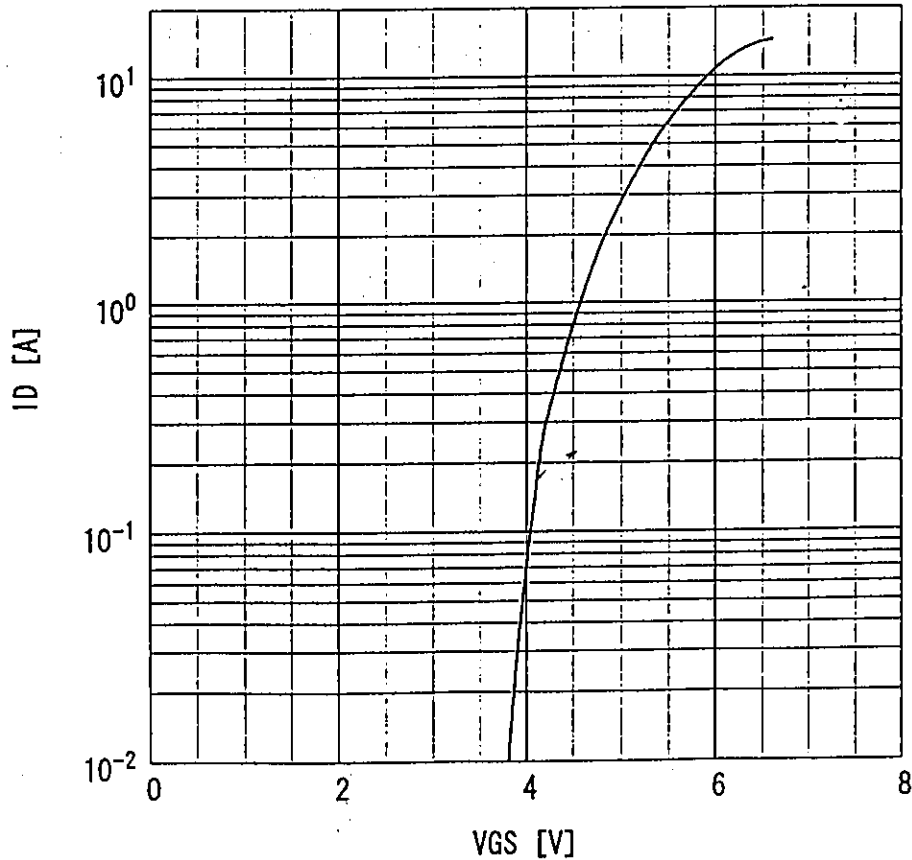
$$ID = f(V_{DS}) : D = 0.01, T_c = 25^\circ C$$



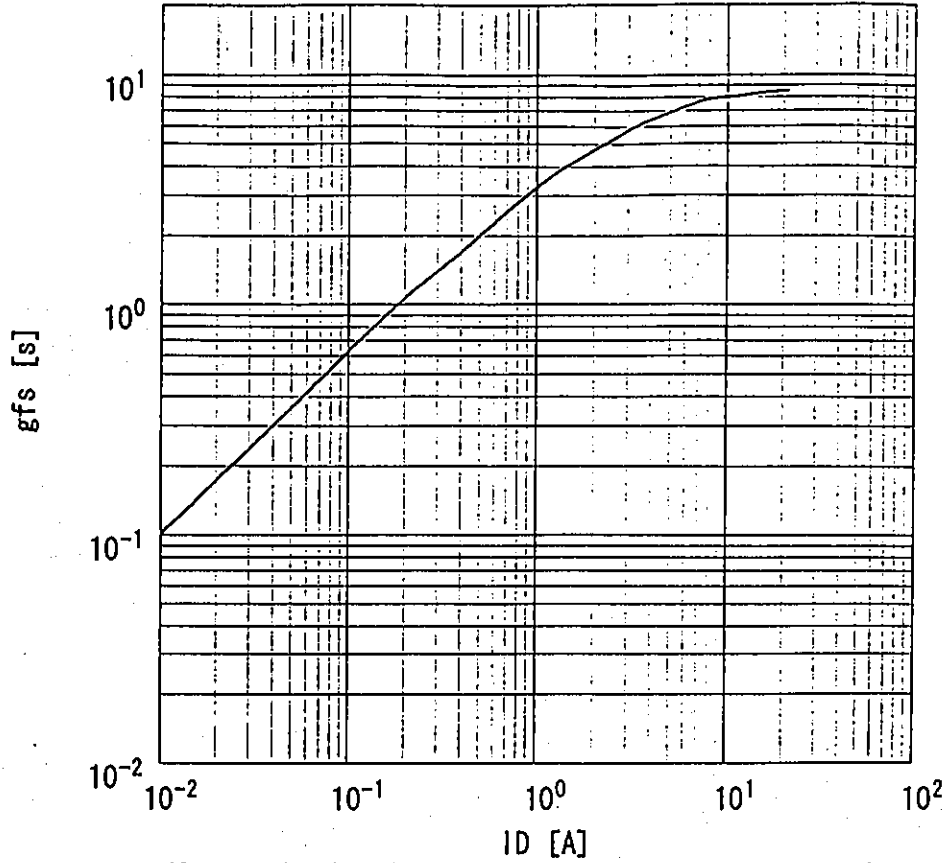
Typical output characteristics  
 $I_D = f(V_{DS})$ :  $80 \mu s$  pulse test,  $T_c = 25^\circ C$



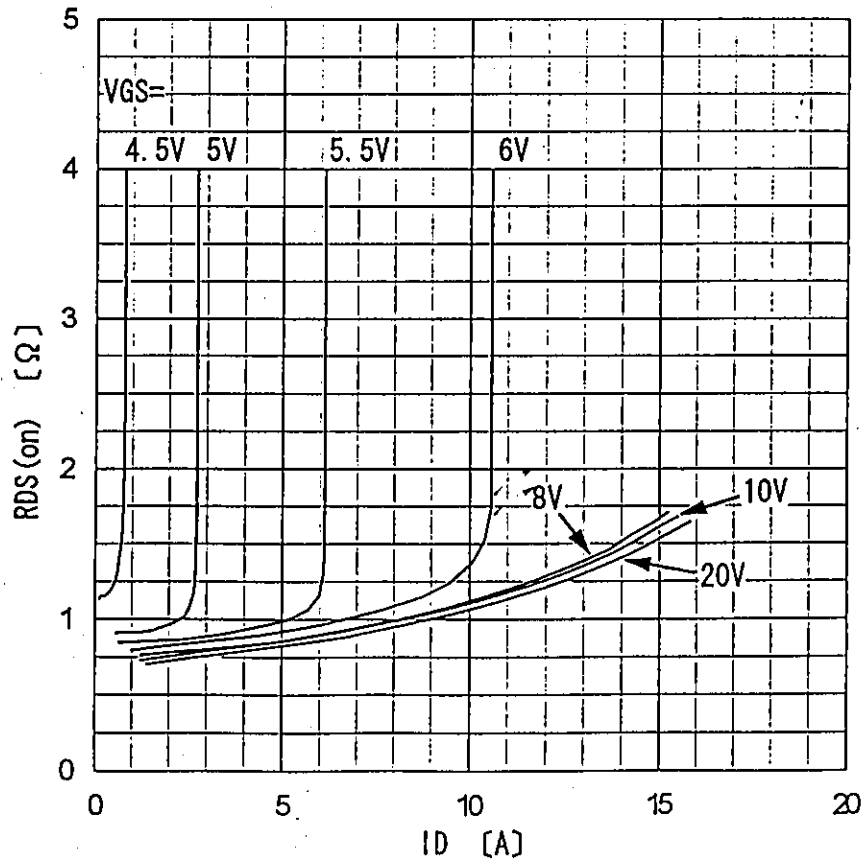
Typical transfer characteristic  
 $I_D = f(V_{GS})$ :  $80 \mu s$  pulse test,  $V_{DS} = 25V$ ,  $T_{ch} = 25^\circ C$



Typical forward transconductance  
 $g_{fs} = f(I_D)$ : 80  $\mu$ s pulse test,  $V_{DS} = 25V$ ,  $T_{ch} = 25^\circ C$

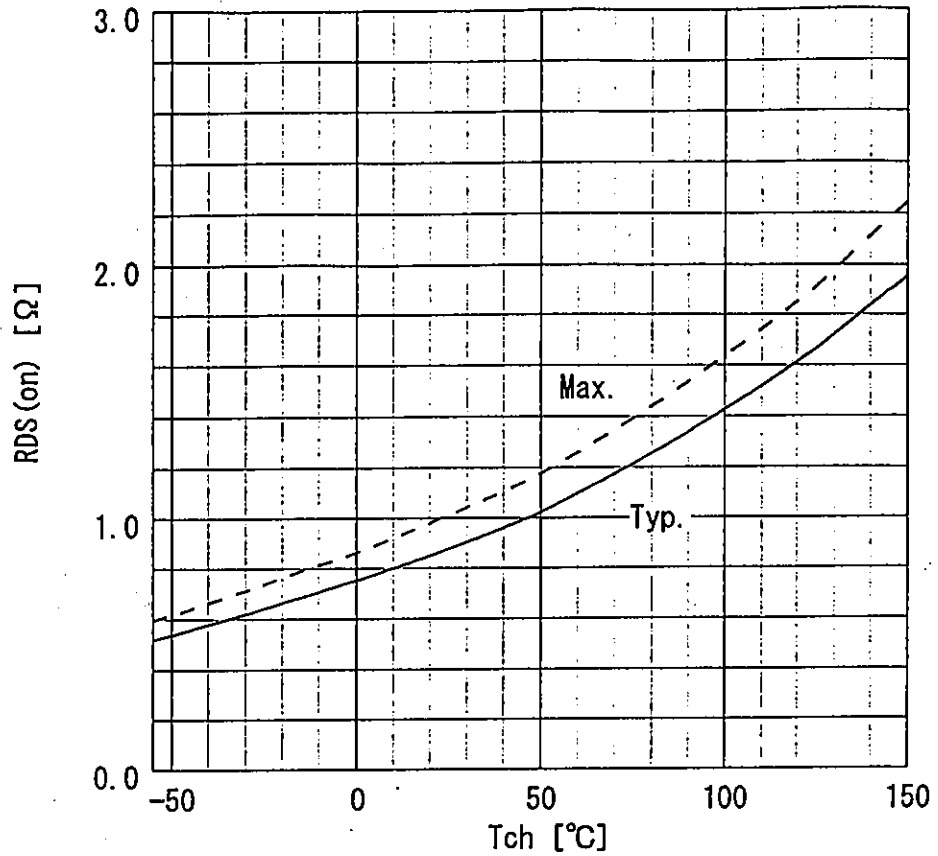


Typical drain-source on-state resistance  
 $R_{DS(on)} = f(I_D)$ :  $T_{ch} = 25^\circ C$

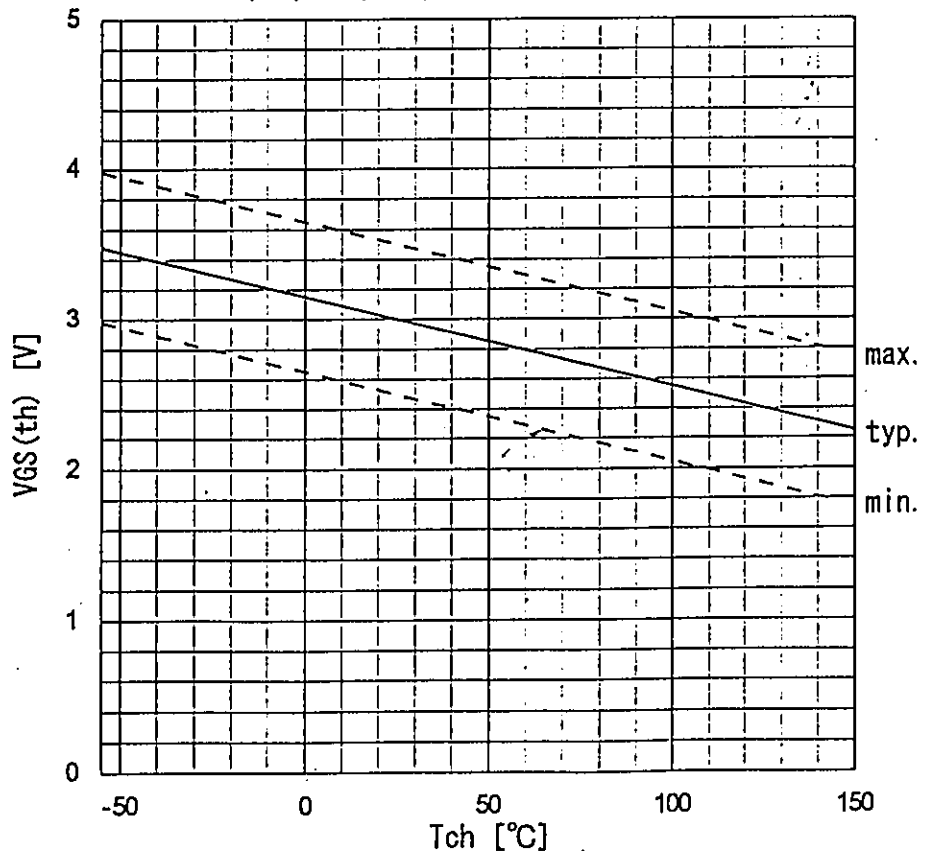




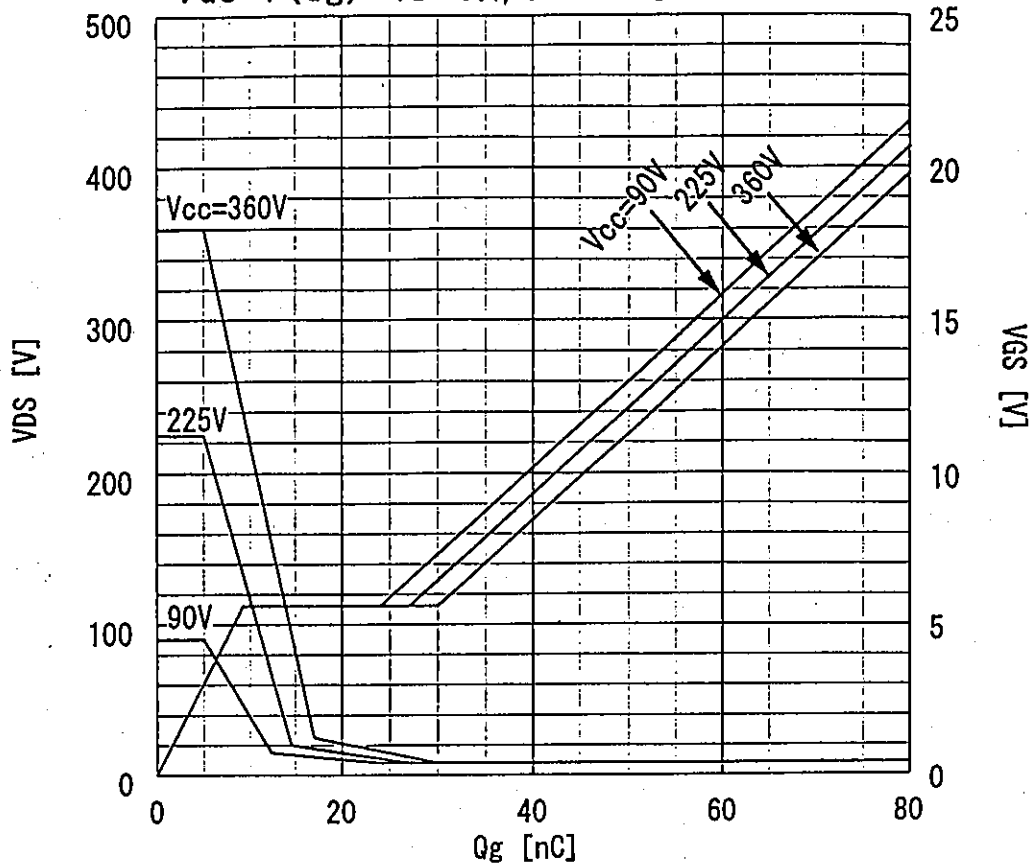
Drain-source on-state resistance  
 $R_{DS(on)} = f(T_{ch}) : I_D = 4.5A, V_{GS} = 10V$



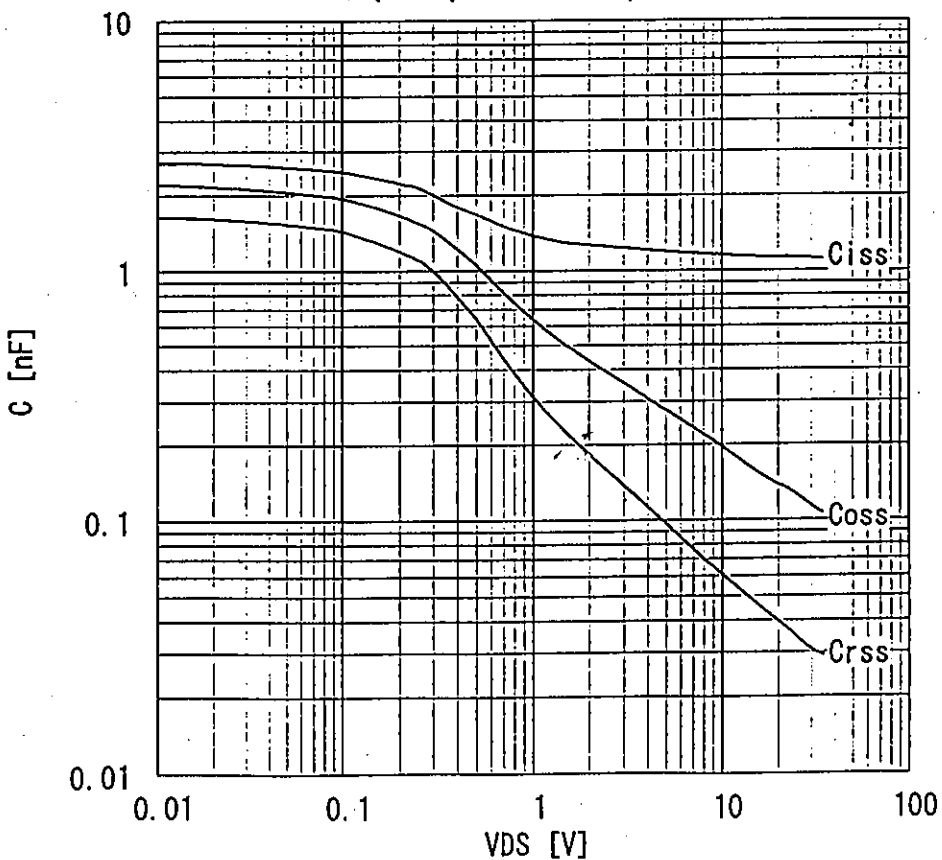
Gate threshold voltage  
 $V_{GS(th)} = f(T_{ch}) : I_D = 1mA, V_{DS} = V_{GS}$



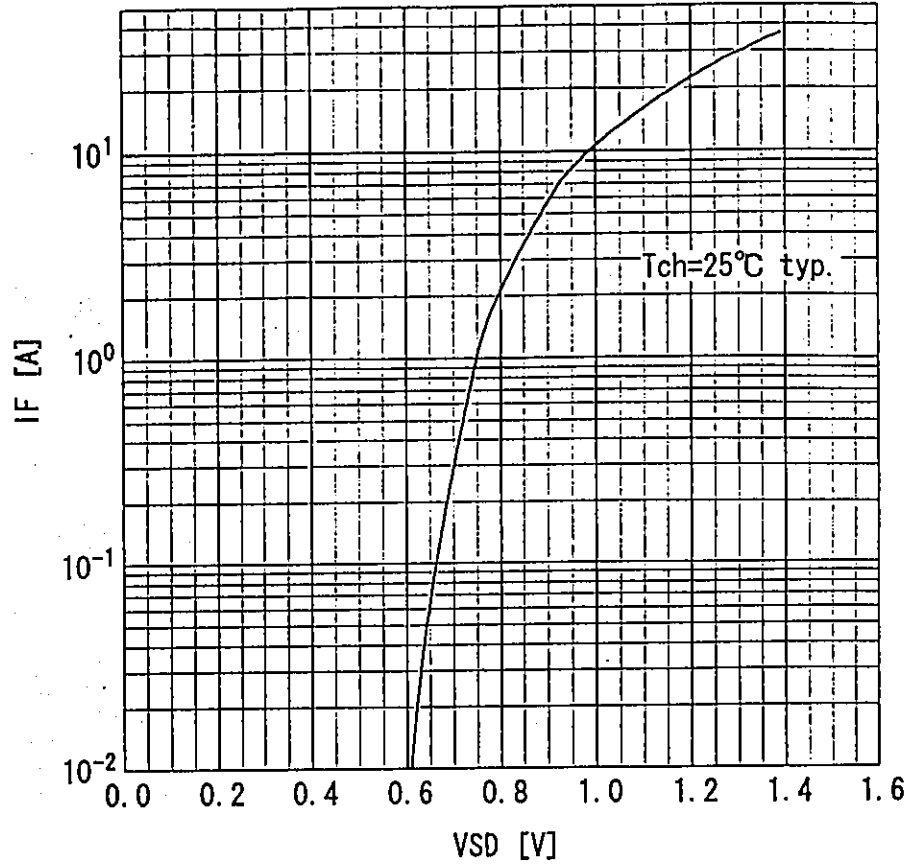
Typical gate charge characteristic  
 $V_{GS} = f(Q_g) : I_D = 9A, T_c = 25^\circ C$



Typical capacitances  
 $C = f(V_{DS}) : V_{GS} = 0V, f = 1MHz$



Forward characteristic of reverse diode  
 $I_F = f(V_{SD})$ : 80  $\mu$ s pulses test,  $V_{GS} = 0V$



Transient thermal impedance  
 $Z_{thch} = f(t)$  parameter:  $D = t/T$

